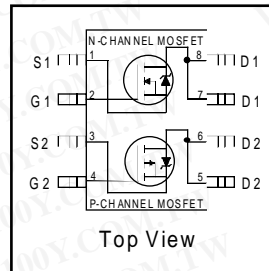


- Generation V Technology
- Ultra Low On-Resistance
- Dual N and P Channel Mosfet
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching

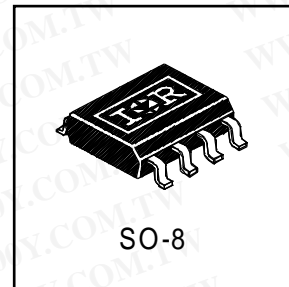


|              | N-Ch   | P-Ch   |
|--------------|--------|--------|
| $V_{DSS}$    | 20V    | -20V   |
| $R_{DS(on)}$ | 0.050Ω | 0.090Ω |

### Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.



### Absolute Maximum Ratings

|                                | Parameter   | Max.         |           | Units |
|--------------------------------|---|--------------|-----------|-------|
|                                |   | N-Channel    | P-Channel |       |
| $I_D @ T_A = 25^\circ\text{C}$ | 10 Sec. Pulse Drain Current, $V_{GS} @ 4.5\text{V}$ | 5.7          | -4.7      | A     |
| $I_D @ T_A = 25^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 4.5\text{V}$    | 5.2          | -4.3      |       |
| $I_D @ T_A = 70^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 4.5\text{V}$    | 4.1          | -3.4      |       |
| $I_{DM}$                       | Pulsed Drain Current ①                              | 21           | -17       |       |
| $P_D @ T_A = 25^\circ\text{C}$ | Power Dissipation                                   | 2.0          |           | W     |
|                                | Linear Derating Factor                              | 0.016        |           | W/°C  |
| $V_{GS}$                       | Gate-to-Source Voltage                              | ± 12         |           | V     |
| dv/dt                          | Peak Diode Recovery dv/dt ②                         | 5.0          | -5.0      | V/ns  |
| $T_J, T_{STG}$                 | Junction and Storage Temperature Range              | -55 to + 150 |           | °C    |

### Thermal Resistance Ratings

|                 | Parameter                    | Typ. | Max. | Units |
|-----------------|------------------------------|------|------|-------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient④ | —    | 62.5 | °C/W  |

# IRF7307

勝特力材料 886-3-5753170

胜特力电子(上海) 86-21-54151736

胜特力电子(深圳) 86-755-83298787

Http://www.100y.com.tw

International  
IR Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| Parameter                       | Description                          |      | Min.  | Typ.   | Max.      | Units               | Conditions  |
|---------------------------------|--------------------------------------|------|-------|--------|-----------|---------------------|---|
|                                 |                                      |      |       |        |           |                     |   |
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | N-Ch | 20    | —      | —         | V                   | $V_{GS} = 0V, I_D = 250\mu A$                         |
|                                 |                                      | P-Ch | -20   | —      | —         |                     | $V_{GS} = 0V, I_D = -250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | N-Ch | —     | 0.044  | —         | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$     |
|                                 |                                      | P-Ch | —     | -0.012 | —         |                     | Reference to $25^\circ\text{C}, I_D = -1\text{mA}$    |
| $R_{DS(ON)}$                    | Static Drain-to-Source On-Resistance | N-Ch | —     | —      | 0.050     | $\Omega$            | $V_{GS} = 4.5V, I_D = 2.6A$ ③                         |
|                                 |                                      |      | —     | —      | 0.070     |                     | $V_{GS} = 2.7V, I_D = 2.2A$ ③                         |
|                                 |                                      | P-Ch | —     | —      | 0.090     |                     | $V_{GS} = -4.5V, I_D = -2.2A$ ③                       |
|                                 |                                      |      | —     | —      | 0.140     |                     | $V_{GS} = -2.7V, I_D = -1.8A$ ③                       |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | N-Ch | 0.70  | —      | —         | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
|                                 |                                      | P-Ch | -0.70 | —      | —         |                     | $V_{DS} = V_{GS}, I_D = -250\mu A$                    |
| $g_{fs}$                        | Forward Transconductance             | N-Ch | 8.30  | —      | —         | S                   | $V_{DS} = 15V, I_D = 2.6A$ ③                          |
|                                 |                                      | P-Ch | 4.00  | —      | —         |                     | $V_{DS} = -15V, I_D = -2.2A$ ③                        |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | N-Ch | —     | —      | 1.0       | $\mu A$             | $V_{DS} = 16V, V_{GS} = 0V$                           |
|                                 |                                      | P-Ch | —     | —      | -1.0      |                     | $V_{DS} = -16V, V_{GS} = 0V,$                         |
|                                 |                                      | N-Ch | —     | —      | 25        |                     | $V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$  |
|                                 |                                      | P-Ch | —     | —      | -25       |                     | $V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | N-P  | —     | —      | $\pm 100$ |                     | $V_{GS} = \pm 12V$                                    |
| $Q_g$                           | Total Gate Charge                    | N-Ch | —     | —      | 20        | $nC$                | N-Channel   |
|                                 |                                      | P-Ch | —     | —      | 22        |                     | $I_D = 2.6A, V_{DS} = 16V, V_{GS} = 4.5V$             |
| $Q_{gs}$                        | Gate-to-Source Charge                | N-Ch | —     | —      | 2.2       | $nC$                | ③   |
|                                 |                                      | P-Ch | —     | —      | 3.3       |                     |   |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | N-Ch | —     | —      | 8.0       | $nC$                | P-Channel   |
|                                 |                                      | P-Ch | —     | —      | 9.0       |                     | $I_D = -2.2A, V_{DS} = -16V, V_{GS} = -4.5V$          |
| $t_{d(on)}$                     | Turn-On Delay Time                   | N-Ch | —     | 9.0    | —         | $ns$                | ③   |
|                                 |                                      | P-Ch | —     | 8.4    | —         |                     |   |
| $t_r$                           | Rise Time                            | N-Ch | —     | 42     | —         | $ns$                | ③   |
|                                 |                                      | P-Ch | —     | 26     | —         |                     |   |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | N-Ch | —     | 32     | —         | $ns$                | ③   |
|                                 |                                      | P-Ch | —     | 51     | —         |                     |   |
| $t_f$                           | Fall Time                            | N-Ch | —     | 51     | —         | $ns$                | ③   |
|                                 |                                      | P-Ch | —     | 33     | —         |                     |   |
| $L_D$                           | Internal Drain Inductance            | N-P  | —     | 4.0    | —         | $nH$                | Between lead tip and center of die contact            |
| $L_S$                           | Internal Source Inductance           | N-P  | —     | 6.0    | —         |                     |   |
| $C_{iss}$                       | Input Capacitance                    | N-Ch | —     | 660    | —         | $pF$                | ③   |
|                                 |                                      | P-Ch | —     | 610    | —         |                     |   |
| $C_{oss}$                       | Output Capacitance                   | N-Ch | —     | 280    | —         | $pF$                | ③   |
|                                 |                                      | P-Ch | —     | 310    | —         |                     |   |
| $C_{rss}$                       | Reverse Transfer Capacitance         | N-Ch | —     | 140    | —         | $pF$                | ③   |
|                                 |                                      | P-Ch | —     | 170    | —         |                     |   |

## Source-Drain Ratings and Characteristics

| Parameter | Description                            |      | Min.  | Typ. | Max. | Units | Conditions   |
|-----------|--|------|---|------|------|-------|--|
| $I_S$     | Continuous Source Current (Body Diode) | N-Ch | —   | —    | 2.5  | A     |  |
|           |  | P-Ch | —   | —    | -2.5 |       |  |
| $I_{SM}$  | Pulsed Source Current (Body Diode) ①   | N-Ch | —   | —    | 21   | A     |  |
|           |  | P-Ch | —   | —    | -17  |       |  |
| $V_{SD}$  | Diode Forward Voltage                  | N-Ch | —   | —    | 1.0  | V     | $T_J = 25^\circ\text{C}, I_S = 1.8A, V_{GS} = 0V$ ③  |
|           |  | P-Ch | —   | —    | -1.0 |       | $T_J = 25^\circ\text{C}, I_S = -1.8A, V_{GS} = 0V$ ③ |
| $t_{rr}$  | Reverse Recovery Time                  | N-Ch | —   | 29   | 44   | $ns$  | ③  |
|           |  | P-Ch | —   | 56   | 84   |       |  |
| $Q_{rr}$  | Reverse Recovery Charge                | N-Ch | —   | 22   | 33   | $nC$  | ③  |
|           |  | P-Ch | —   | 71   | 110  |       |  |
| $t_{on}$  | Forward Turn-On Time                   | N-P  | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |       |  |

### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 23 )

③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

② N-Channel  $I_{SD} \leq 2.6A, di/dt \leq 100A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$   
P-Channel  $I_{SD} \leq -2.2A, di/dt \leq 50A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$

④ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

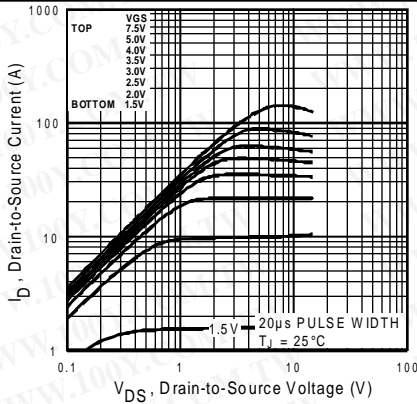


Fig 1. Typical Output Characteristics

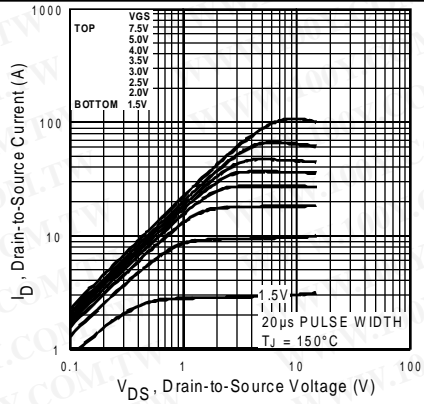


Fig 2. Typical Output Characteristics

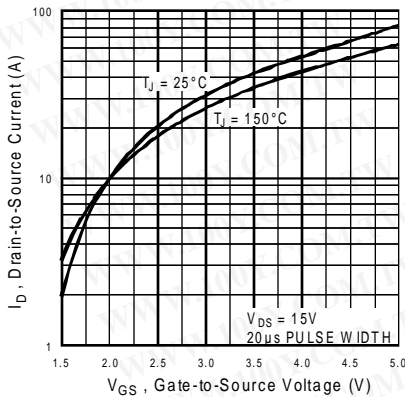


Fig 3. Typical Transfer Characteristics

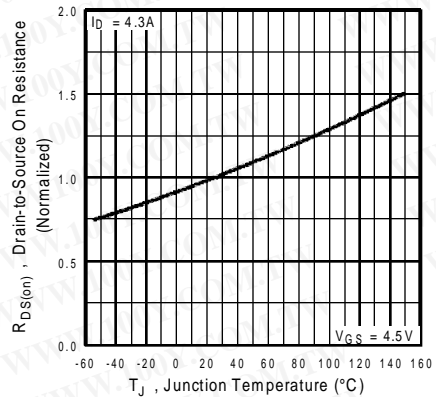


Fig 4. Normalized On-Resistance Vs. Temperature

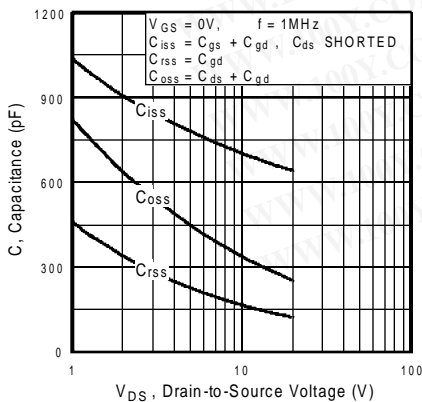


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

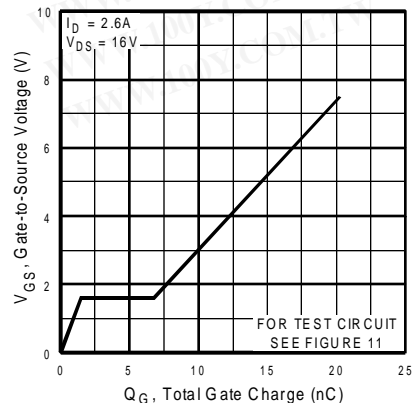
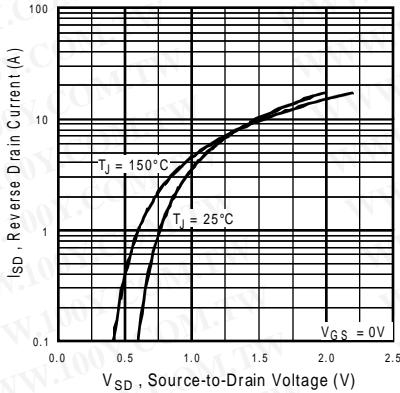


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

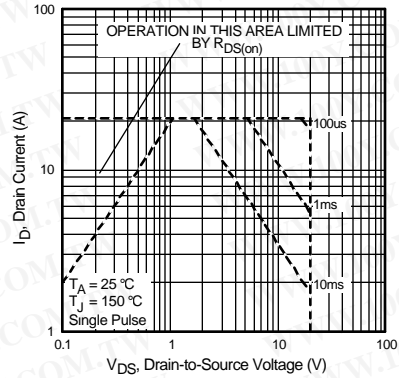
# IRF7307

N-Channel

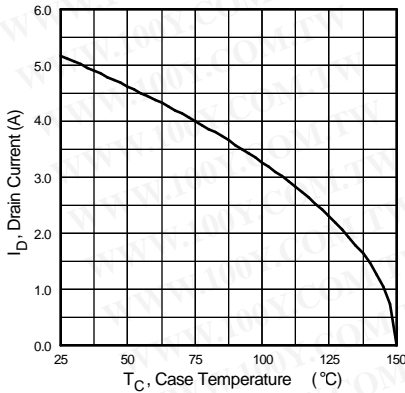
International  
**IR** Rectifier



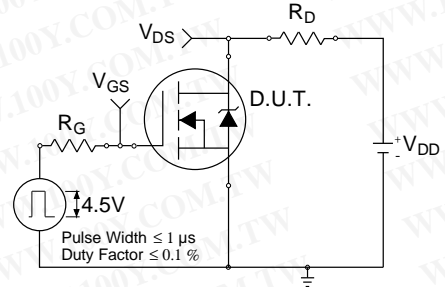
**Fig 7.** Typical Source-Drain Diode Forward Voltage



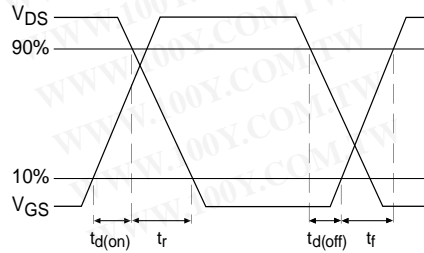
**Fig 8.** Maximum Safe Operating Area



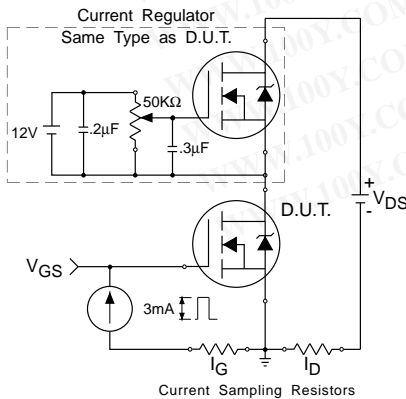
**Fig 9.** Maximum Drain Current Vs. Ambient Temperature



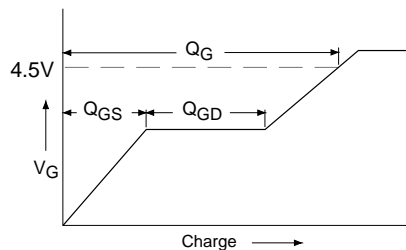
**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11a.** Gate Charge Test Circuit



**Fig 11b.** Basic Gate Charge Waveform

P-Channel

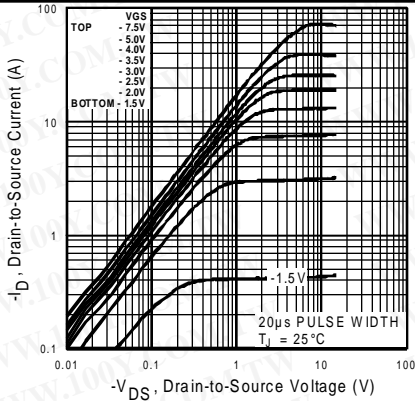


Fig 12. Typical Output Characteristics

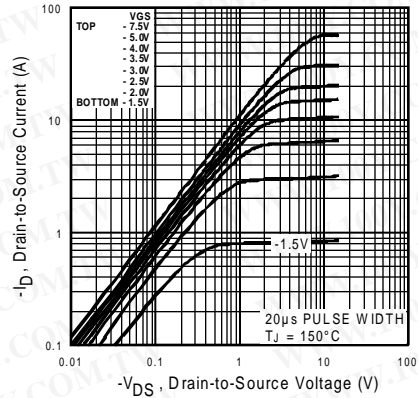


Fig 13. Typical Output Characteristics

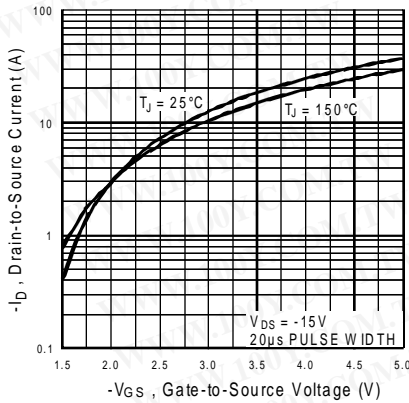


Fig 14. Typical Transfer Characteristics

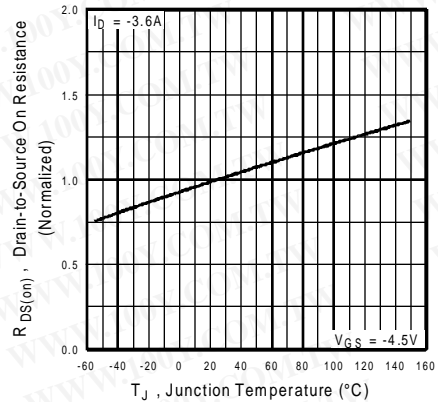


Fig 15. Normalized On-Resistance Vs. Temperature

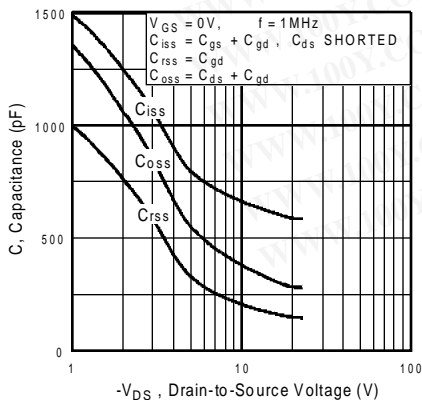


Fig 16. Typical Capacitance Vs. Drain-to-Source Voltage

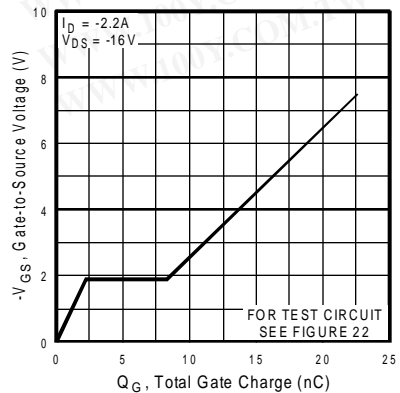
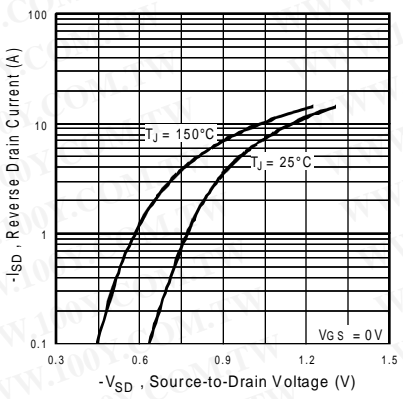


Fig 17. Typical Gate Charge Vs. Gate-to-Source Voltage

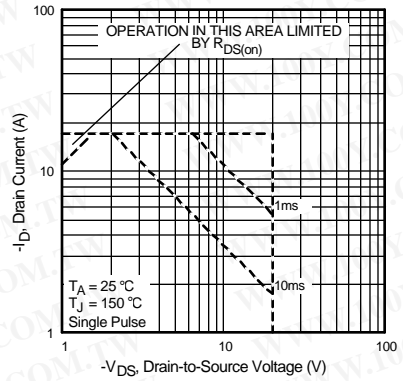
# IRF7307

P-Channel

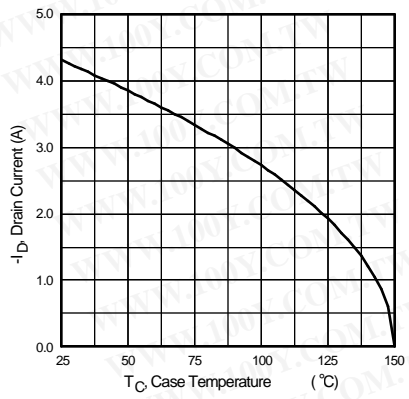
International  
**IR** Rectifier



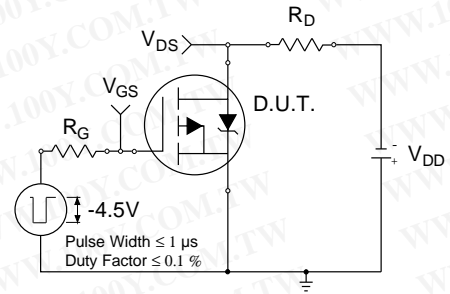
**Fig 18.** Typical Source-Drain Diode Forward Voltage



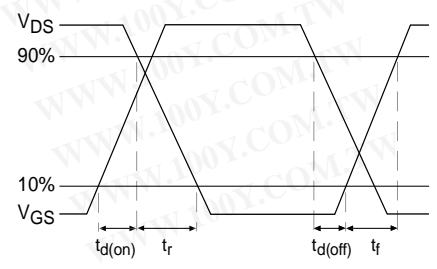
**Fig 19.** Maximum Safe Operating Area



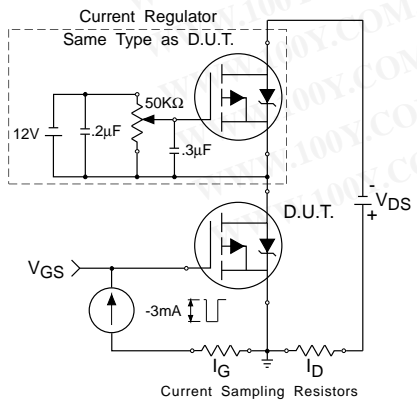
**Fig 20.** Maximum Drain Current Vs. Ambient Temperature



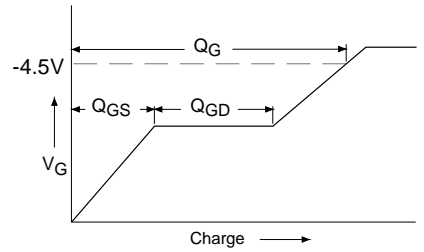
**Fig 21a.** Switching Time Test Circuit



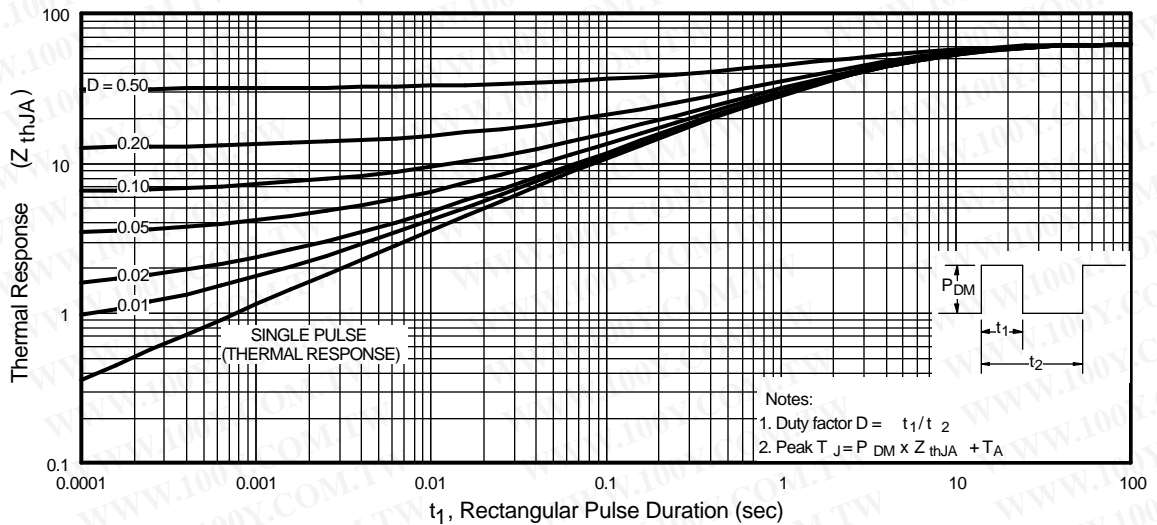
**Fig 21b.** Switching Time Waveforms



**Fig 22a.** Gate Charge Test Circuit



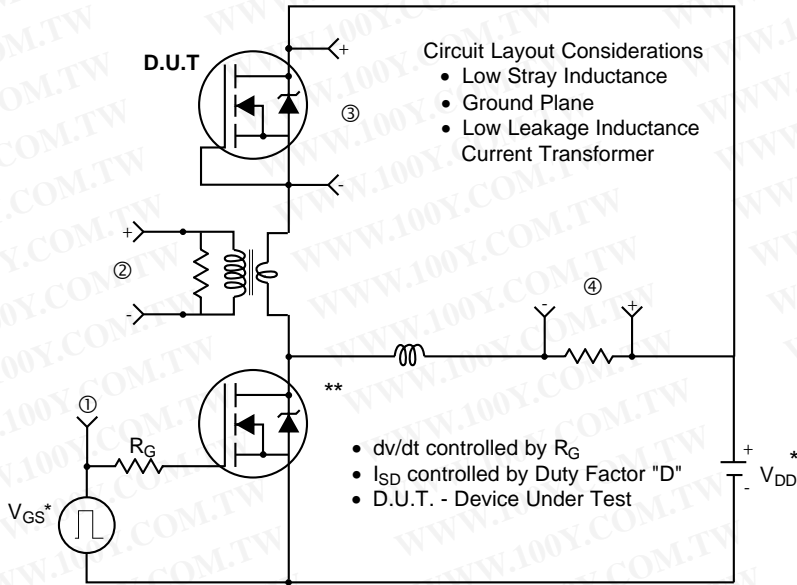
**Fig 22b.** Basic Gate Charge Waveform



**Fig 23.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

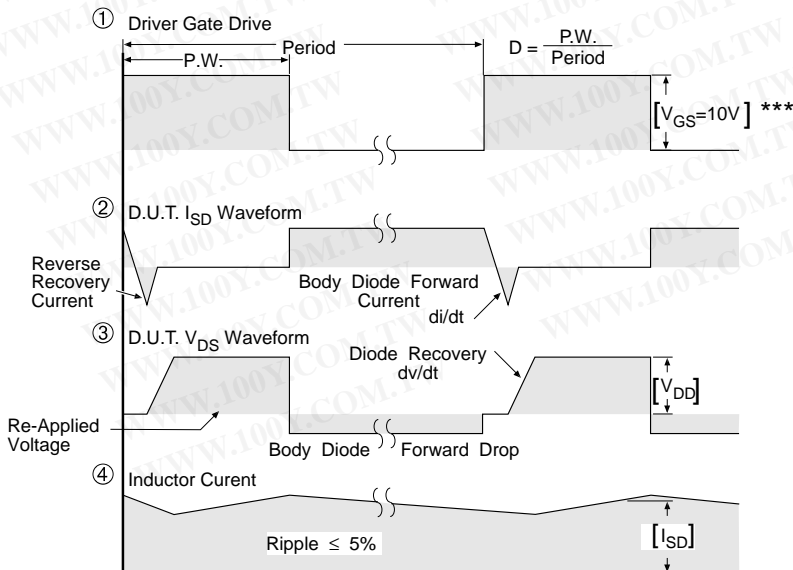
勝特力材料 886-3-5753170  
 勝特力电子(上海) 86-21-54151736  
 勝特力电子(深圳) 86-755-83298787  
[Http://www.100y.com.tw](http://www.100y.com.tw)

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity for P-Channel

\*\* Use P-Channel Driver for P-Channel Measurements



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and  $3V$  Drive Devices

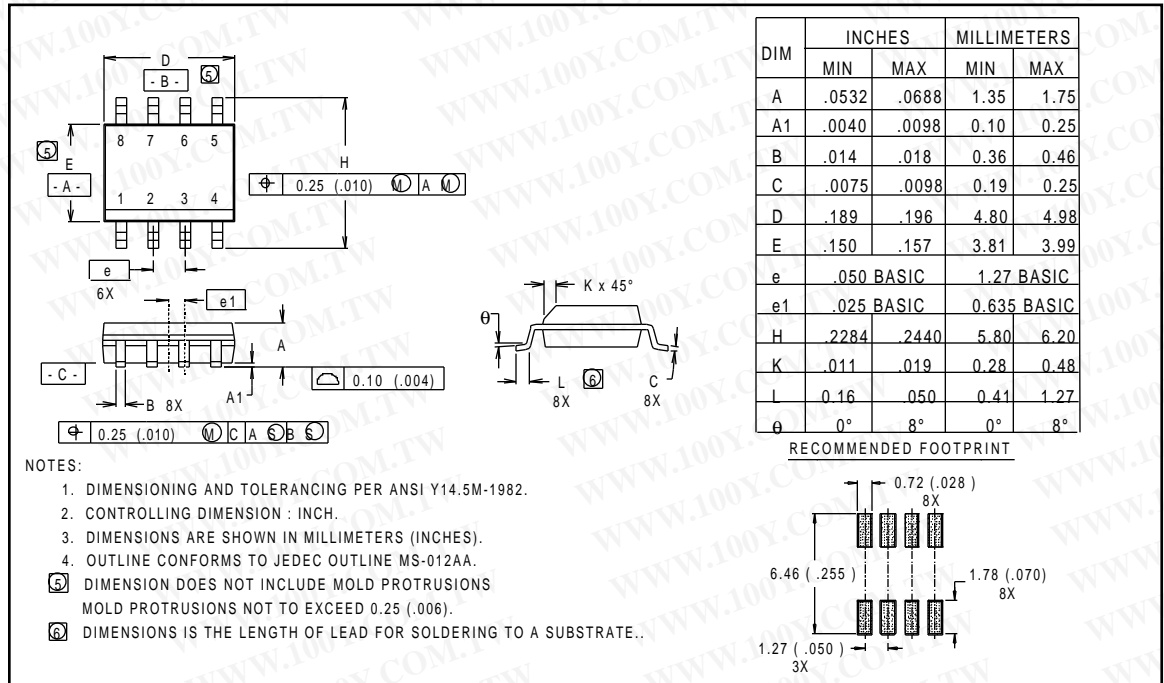
**Fig 24.** For N and P Channel HEXFETS



## Package Outline

### SO-8 Outline

Dimensions are shown in millimeters (inches)



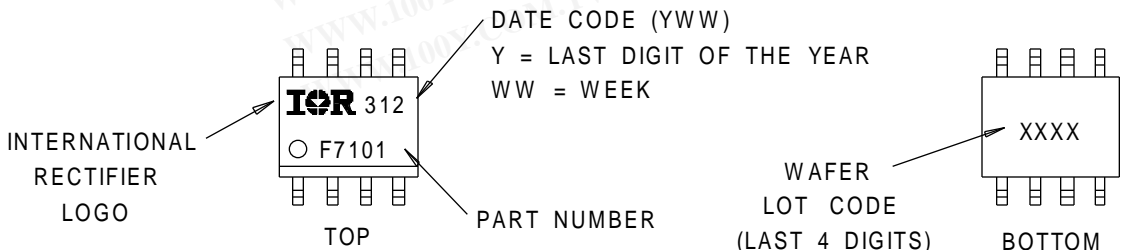
**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
  2. CONTROLLING DIMENSION : INCH.
  3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
  4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- Ⓢ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS  
 MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).
- Ⓢ DIMENSIONS IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

## Part Marking Information

### SO-8

EXAMPLE : THIS IS AN IRF7101



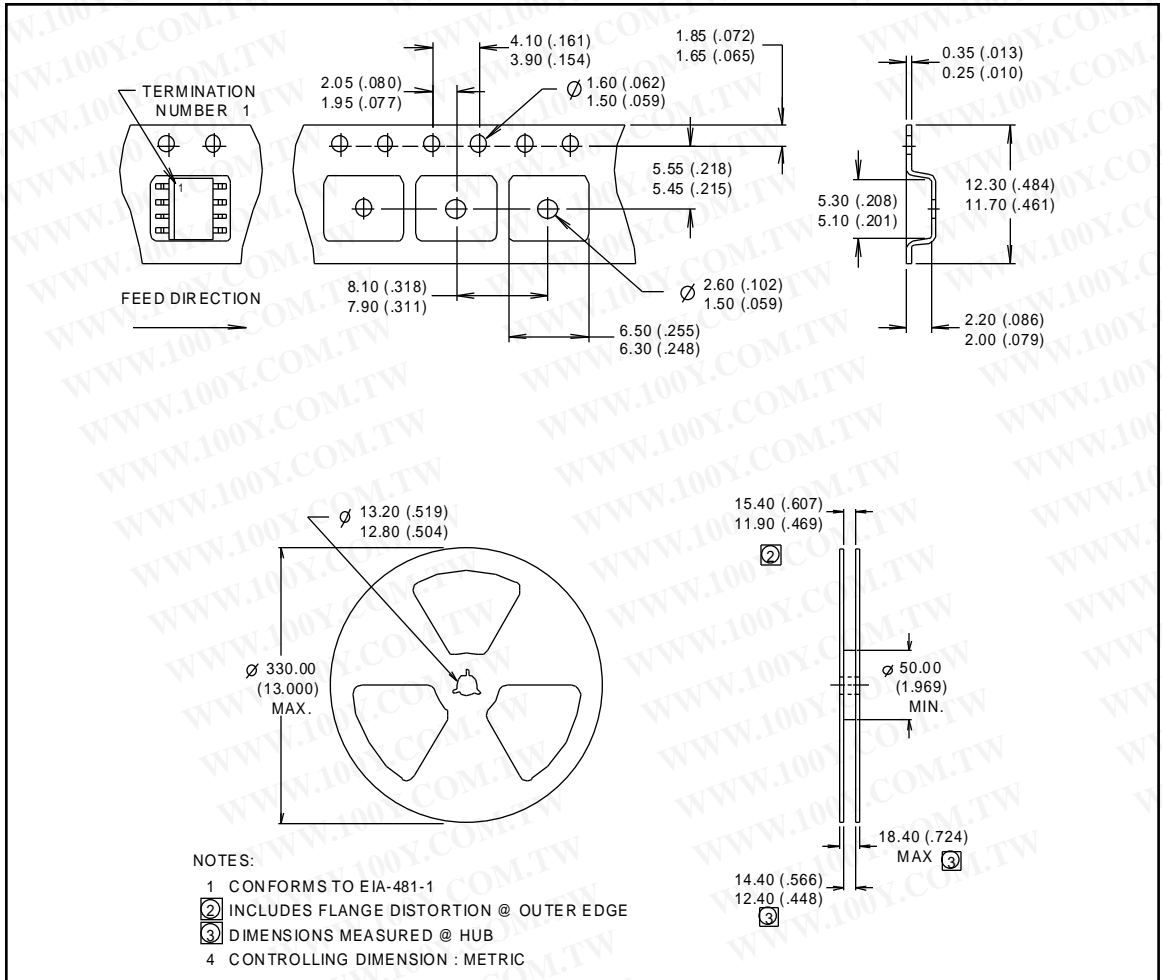
# IRF7307

勝特力材料 886-3-5753170  
勝特力电子(上海) 86-21-54151736  
勝特力电子(深圳) 86-755-83298787  
[Http://www.100y.com.tw](http://www.100y.com.tw)

International  
**IOR** Rectifier

## Tape & Reel Information SO-8

Dimensions are shown in millimeters (inches)



International  
**IOR** Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331  
**EUROPEAN HEADQUARTERS:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

<http://www.irf.com/> Data and specifications subject to change without notice.

8/97